

Case Docket No. HEIWA.026AUS

Date: May 21, 2007

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Applicant(s)

Noriaki Chiba

App. No.

10/538,595

Filed

June 9, 2005

For

Julie 9, 2005

TIMING GENERATION CIRCUIT AND

SEMICONDUCTOR TEST DEVICE HAVING

THE TIMING GENERATION CIRCUIT

Examiner

Richard Isla Rodas

Art Unit

2829

Yasuo Muramatsu, Reg. No. 38,684

May 21, 2007

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal

Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-

1450, on

COMMISSIONER FOR PATENTS ALEXANDRIA, VA 22313-1450

Sir:

Transmitted herewith is a response to the office action in the above-identified utility application.

() An extension of time to respond for \* month(s) is hereby requested.

Time Extension Fee:

- () one month (\$120 large entity)
- () two months (\$450 large entity)
- () three months (\$1020 large entity)

Enclosed are:

- (X) Amendment in thirty three (33) pages.
- (X) Return prepaid postcard.

Vasyo Muramatsu Registration No. 38,684

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TRS-HW26.002 051807

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

plicant : Noriaki Chiba

Group Art Unit 2829

Serial No. : 10/538,595

Filed : June 9, 2005

For : TIMING GENERATION CIRCUIT

AND SEMICONDUCTOR TEST DEVICE HAVING THE TIMING

GENERATION CIRCUIT

Examiner : Isla Rodas, Richard

## **AMENDMENT**

Hon. Commissioner of Patents and Trademarks Alexandria, VA 22313-1450

## Dear Sir:

This amendment is submitted in response to the office action mailed February 22, 2007 from the United States Patent and Trademark Office for the above-identified patent application. Please make the following changes: